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(Substitute) PTO/SB/21 (09-04)

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TRANSMITTAL FORM

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Total Number of Pages in This Submission

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Application Number

10/536,674

Filing Date

July 29, 2005

First Named Inventor

Torsten MULLER

Art Unit

1651

Examiner Name

Attorney Docket Number

B1180/20038

ENCLOSURES

(Check all that apply)

☐

Fee Transmittal Form

☐

Fee Attached

☐

Amendment/Reply

☐

After Final

☐

Affidavits/declaration(s)

☐

Extension of Time Request

☐

Express Abandonment Request

☒

Information Disclosure Statement

☐

Certified Copy of Priority Document(s)

☐

Reply to Missing Parts/ Incomplete Application

☐

Reply to Missing Parts under 37 CFR 1.52 or 1.53

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Drawing(s)

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Licensing-related Papers

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Petition

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Petition to Convert to a Provisional Application

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Power of Attorney, Revocation

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Change of Correspondence Address

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Terminal Disclaimer

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Appeal Communication to Board of Appeals and Interferences

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Appeal Communication to TC (Appeal Notice, Brief, Reply Brief)

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Proprietary Information

☐

Status Letter

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Other Enclosure(s) (please identify below):

Return Receipt Postcard, Form PTO 1449/A, 4 foreign patent documents and 6 non-patent literature documents

Remarks

Please charge Attorney Account No. 03-0075 as necessary to effect entry and/or ensure consideration of this submission.

SIGNATURE OF APPLICANT, ATTORNEY, OR AGENT

Firm Name

Caesar, Rivise, Bernstein, Cohen & Pokotilow, Ltd., Customer No. 03000

Signature

Printed name

David M. Tener

Date

October 26, 2005

Reg. No.

37,054

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David M. Tener

Date

October 26, 2005

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PATENT

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE
PATENT EXAMINING OPERATION

Applicant(s): Torsten MÜLLER et al.

Serial No: 10/536,674

Group Art Unit: 1651

Filed: July 29, 2005

Examiner:

Att. Docket No.: B1180/20038

Confirmation No.: 9821

For: FLUIDIC MICROSYSTEM COMPRISING FIELD-FORMING PASSIVATION
LAYERS PROVIDED ON MICROELECTRODES

INFORMATION DISCLOSURE STATEMENT

Mail Stop AMENDMENTS
Commissioner for Patents
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Sir:

Pursuant to 37 CFR §1.56, the attention of the Patent and Trademark Office is hereby directed to the reference(s) listed on the attached PTO-1449. Unless otherwise indicated herein, one copy of each reference is attached. No copies of U.S. patents or U.S. patent application publications are attached. 37 CFR § 1.98(a)(2)(ii). It is respectfully requested that the information be expressly considered during the prosecution of this application, and that the reference(s) be made of record therein and appear among the "References Cited" on any patent to issue therefrom. No representation is made that the reference(s) is/are prior art with respect to this application.

This Information Disclosure Statement is being filed within three months of the filing date of a national application other than a CPA under 37 CFR § 1.53(d), within three months of the date of entry of the national stage as set forth in 37 CFR § 1.491 in an international application, before the mailing of a first Office Action on the merits, or before the mailing of a first Office Action after the filing of an RCE under 37 CFR § 1.114. No certification or fee is required. 37 CFR § 1.97(b).

Application No. 10/536,674
IDS dated October 26, 2005

U.S. Patent Application No. 6,749,736 B1 is an English-language counterpart of DE 198 60 117 and DE 198 60 118. U.S. Patent Application No. 6,727,451 B1 is an English-language counterpart of DE 198 15 882.

Respectfully submitted,

CAESAR, RIVISE, BERNSTEIN,
COHEN & POKOTILOW, LTD.

October 26, 2005

Please charge or credit our Account
No. 03-0075 as necessary to effect
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this submission.

By 

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Substitute for Form 1449A/PTO

**INFORMATION DISCLOSURE
STATEMENT BY APPLICANT**

(use as many sheet as necessary)

Complete if Known

Application Number	10/536,674
Filing Date	July 29, 2005
First Named Inventor	Torsten MÜLLER
Group Art Unit	1651
Examiner Name	
Attorney Docket Number	B1180/20038

Sheet	1	of	1
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U.S. PATENT DOCUMENTS

Examiner Initials*	Cite No.	U.S. Patent Document		Name of Patentee or Applicant of Cited Document	Date of Publication of Cited Document MM-DD-YYYY
		Number	Kind Code (if known)		
/A.N./		6,113,768		FUHR et al.	09-05-2000
/A.N./		6,387,707	B1	SEUL et al.	05-14-2002
/A.N./		2002/0166766	A1	SEUL et al.	11-14-2002
/A.N./		6,727,451	B1	FUHR et al.	04-27-2004
/A.N./		6,749,736	B1	FUHR et al.	06-15-2004

FOREIGN PATENT DOCUMENTS

Examiner Initials*	Cite No.	Foreign Patent Document			Name of Patentee or Applicant of Cited Document	Date of Publication of Cited Document MM-DD-YYYY	T
		Office	Number	Kind Code (if known)			
/A.N./		WO	00/69565	A1	MEDORO	11-23-2000	
/A.N./		DE	198 15 882	A1	FUHR et al.	10-14-1999	
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/A.N./		DE	198 60 118	C1	FUHR et al.	09-28-2000	

OTHER DOCUMENTS - NON PATENT LITERATURE DOCUMENTS

Examiner Initials*	Cite No.	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.	T
/A.N./		CUMMINGS, et al., "Dielectrophoretic Trapping Without Embedded Electrodes", Proceedings of SPIE Vol. 4177 (2000); pp. 164-173	
/A.N./		FUHR, et al., "Electric-field-mediated inhibition of cell and microparticle adhesion: a new way to create bio-repellent surfaces", Sensors and Actuators B 26-27 (1995); pp. 468-470	
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/A.N./		MÜLLER, et al., "A 3-D microelectrode system for handling and caging single cells and particles", Biosensors and Bioelectronics 14 (1999); pp. 247-256	
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/A.N./		SCHNELLE, et al., "Adhesion-Inhibited Surfaces. Coated and Uncoated Interdigitated Electrode Arrays in the Micrometer and Submicrometer Range", Langmuir 12 (1996); pp. 801-809	

EXAMINER /Alexander Noguerola/

DATE CONSIDERED

03/01/2008

*Examiner: Initial if citation considered, whether or not citation is in conformance with MPEP § 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.